8-bit serial-in, parallel-out shift register Rev. 5 — 25 November 2010

Product data sheet

1. **General description**

The 74HC164; 74HCT164 are high-speed Si-gate CMOS devices and are pin compatible with Low power Schottky TTL (LSTTL). They are specified in compliance with JEDEC standard no. 7A.

The 74HC164; 74HCT164 are 8-bit edge-triggered shift registers with serial data entry and an output from each of the eight stages. Data is entered serially through one of two inputs (DSA or DSB); either input can be used as an active HIGH enable for data entry through the other input. Both inputs must be connected together or an unused input must be tied HIGH.

Data shifts one place to the right on each LOW-to-HIGH transition of the clock (CP) input and enters into Q0, which is the logical AND of the two data inputs (DSA and DSB) that existed one set-up time prior to the rising clock edge.

A LOW level on the master reset (\overline{MR}) input overrides all other inputs and clears the register asynchronously, forcing all outputs LOW.

Features and benefits 2.

- Input levels:
 - For 74HC164: CMOS level
 - For 74HCT164: TTL level
- Gated serial data inputs
- Asynchronous master reset
- Complies with JEDEC standard no. 7A
- ESD protection:
 - HBM JESD22-A114F exceeds 2000 V
 - MM JESD22-A115-A exceeds 200 V.
- Multiple package options
- Specified from -40 °C to +85 °C and -40 °C to +125 °C.

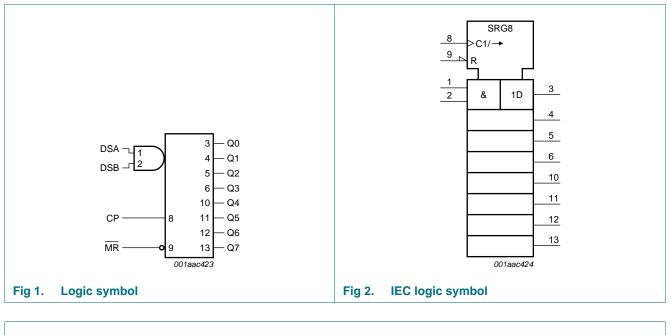


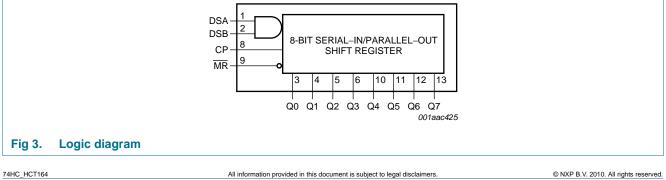
8-bit serial-in, parallel-out shift register

3. Ordering information

Table 1. Ord	lering information			
Type number	Package			
	Temperature range	Name	Description	Version
74HC164N	–40 °C to +125 °C	DIP14	plastic dual in-line package; 14 leads (300 mil)	SOT27-1
74HCT164N				
74HC164D	–40 °C to +125 °C	SO14	plastic small outline package; 14 leads; body width	SOT108-1
74HCT164D			3.9 mm	
74HC164DB	–40 °C to +125 °C	SSOP14	plastic shrink small outline package; 14 leads; body	SOT337-1
74HCT164DB			width 5.3 mm	
74HC164PW	–40 °C to +125 °C	TSSOP14	plastic thin shrink small outline package; 14 leads;	SOT402-1
74HCT164PW			body width 4.4 mm	
74HC164BQ	–40 °C to +125 °C	DHVQFN14	plastic dual in-line compatible thermal enhanced very	SOT762-1
74HCT164BQ			thin quad flat package; no leads; 14 terminals; body $2.5 \times 3 \times 0.85$ mm	

4. Functional diagram

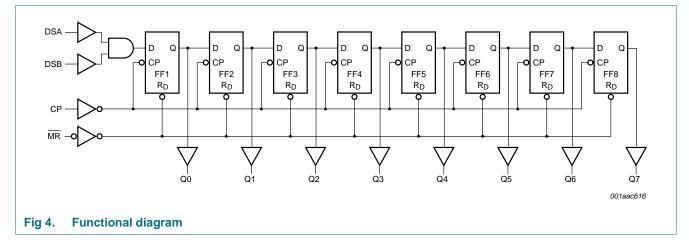




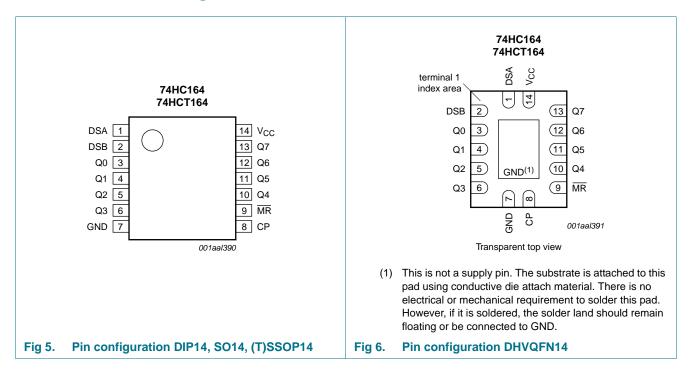
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5. Pinning information



5.1 Pinning

8-bit serial-in, parallel-out shift register

5.2 Pin description

Table 2.	Pin description	
Symbol	Pin	Description
DSA	1	data input
DSB	2	data input
Q0 to Q7	3, 4, 5, 6, 10, 11, 12, 13	output
GND	7	ground (0 V)
СР	8	clock input (LOW-to-HIGH, edge-triggered)
MR	9	master reset input (active LOW)
V _{CC}	14	positive supply voltage

6. Functional description

Table 3. Function table^[1]

Operating	Input		Output	Output		
modes	MR	СР	DSA	DSB	Q0	Q1 to Q7
Reset (clear)	L	x	X	х	L	L to L
Shift	Н	\uparrow	I	I	L	q0 to q6
	Н	\uparrow	I	h	L	q0 to q6
	Н	\uparrow	h	I	L	q0 to q6
	Н	\uparrow	h	h	Н	q0 to q6

[1] H = HIGH voltage level

h = HIGH voltage level one set-up time prior to the LOW-to-HIGH clock transition

L = LOW voltage level

I = LOW voltage level one set-up time prior to the LOW-to-HIGH clock transition

q = lower case letters indicate the state of the referenced input one set-up time prior to the LOW-to-HIGH clock transition

 \uparrow = LOW-to-HIGH clock transition

7. Limiting values

Table 4.Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to GND (ground = 0 V).

				.0	,
Symbol	Parameter	Conditions	Min	Max	Unit
V _{CC}	supply voltage		-0.5	+7	V
I _{IK}	input clamping current	$V_{\rm I}$ < –0.5 V or $V_{\rm I}$ > $V_{\rm CC}$ + 0.5 V	<u>[1]</u> _	±20	mA
I _{OK}	output clamping current	$V_{\rm O}$ < –0.5 V or $V_{\rm O}$ > $V_{\rm CC}$ + 0.5 V	<u>[1]</u> _	±20	mA
lo	output current	$-0.5 \text{ V} < \text{V}_{\text{O}} < \text{V}_{\text{CC}} + 0.5 \text{ V}$	-	±25	mA
I _{CC}	supply current		-	50	mA
I _{GND}	ground current		-50	-	mA
T _{stg}	storage temperature		-65	+150	°C

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In accordant	ce with the Absolute Maximum R	ating System (IEC 60134). Voltage	s are referenced to GNL) (ground	= 0 V).
Symbol	Parameter	Conditions	Min	Max	Unit
P _{tot}	total power dissipation		[2]		
	DIP14 package		-	750	mW
	SO14, (T)SSOP14 and DHVQFN14 packages		-	500	mW

Table 4. Limiting values ... continued

~ • •

[1] The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

[2] For DIP14 package: Ptot derates linearly with 12 mW/K above 70 °C.

For SO14 package: P_{tot} derates linearly with 8 mW/K above 70 °C.

For (T)SSOP14 packages: Ptot derates linearly with 5.5 mW/K above 60 °C.

For DHVQFN14 packages: Ptot derates linearly with 4.5 mW/K above 60 °C.

Recommended operating conditions 8.

Recommended operating conditions Table 5.

Voltages are referenced to GND (ground = 0 V)

Symbol	Parameter	Conditions	74HC1	74HC164			74HCT164		
			Min	Тур	Max	Min	Тур	Max	
V _{CC}	supply voltage		2.0	5.0	6.0	4.5	5.0	5.5	V
VI	input voltage		0	-	V _{CC}	0	-	V _{CC}	V
Vo	output voltage		0	-	V _{CC}	0	-	V _{CC}	V
T _{amb}	ambient temperature		-40	+25	+125	-40	+25	+125	°C
$\Delta t / \Delta V$	input transition rise and fall rate	$V_{CC} = 2.0 V$	-	-	625	-	-	-	ns/V
		V_{CC} = 4.5 V	-	1.67	139	-	1.67	139	ns/V
		$V_{CC} = 6.0 V$	-	-	83	-	-	-	ns/V

Static characteristics 9.

Table 6. **Static characteristics**

At recommended operating conditions; voltages are referenced to GND (ground = 0 V).

Symbo	Parameter	Conditions		25 °C		-40 °C to	o +85 °C	–40 °C to	o +125 °C	Unit
			Min	Тур	Max	Min	Max	Min	Max	
74HC1	64									
V_{IH}	HIGH-level	$V_{CC} = 2.0 V$	1.5	1.2	-	1.5	-	1.5	-	V
input voltag	input voltage	$V_{CC} = 4.5 V$	3.15	2.4	-	3.15	-	3.15	-	V
		$V_{CC} = 6.0 V$	4.2	3.2	-	4.2	-	4.2	-	V
V_{IL}	LOW-level	$V_{CC} = 2.0 V$	-	0.8	0.5	-	0.5	-	0.5	V
	input voltage	$V_{CC} = 4.5 V$	-	2.1	1.35	-	1.35	-	1.35	V
		$V_{CC} = 6.0 V$	-	2.8	1.8	-	1.8	-	1.8	V

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Symbol	Parameter	Conditions		25 °C		-40 °C te	o +85 °C	–40 °C to	o +125 °C	Unit
-			Min	Тур	Max	Min	Max	Min	Max	
V _{OH}	HIGH-level	$V_{I} = V_{IH}$ or V_{IL}								
	output voltage	$I_{O} = -20 \ \mu A; \ V_{CC} = 2.0 \ V$	1.9	2.0	-	1.9	-	1.9	-	V
		$I_{O} = -20 \ \mu A; \ V_{CC} = 4.5 \ V$	4.4	4.5	-	4.4	-	4.4	-	V
		$I_{O} = -20 \ \mu A; \ V_{CC} = 6.0 \ V$	5.9	6.0	-	5.9	-	5.9	-	V
		$I_{O} = -4.0 \text{ mA}; V_{CC} = 4.5 \text{ V}$	3.98	4.32	-	3.84	-	3.7	-	V
		$I_0 = -5.2 \text{ mA}; V_{CC} = 6.0 \text{ V}$	5.48	5.81	-	5.34	-	5.2	-	V
V _{OL}	LOW-level	$V_{I} = V_{IH} \text{ or } V_{IL}$								
	output voltage	$I_0 = 20 \ \mu A; V_{CC} = 2.0 \ V$	-	0	0.1	-	0.1	-	0.1	V
		$I_{O} = 20 \ \mu A; V_{CC} = 4.5 \ V$	-	0	0.1	-	0.1	-	0.1	V
		$I_{O} = 20 \ \mu A; V_{CC} = 6.0 \ V$	-	0	0.1	-	0.1	-	0.1	V
		I_{O} = 4.0 mA; V_{CC} = 4.5 V	-	0.15	0.26	-	0.33	-	0.4	V
		I_{O} = 5.2 mA; V_{CC} = 6.0 V	-	0.16	0.26	-	0.33	-	0.4	V
I	input leakage current	$V_1 = V_{CC}$ or GND; $V_{CC} = 6.0 V$	-	-	±0.1	-	±1	-	±1	μA
I _{CC}	supply current		-	-	8.0	-	80	-	160	μA
CI	input capacitance		-	3.5	-	-	-	-	-	pF
74HCT1	64									
V _{IH}	HIGH-level input voltage	V_{CC} = 4.5 V to 5.5 V	2.0	1.6	-	2.0	-	2.0	-	V
V _{IL}	LOW-level input voltage	V_{CC} = 4.5 V to 5.5 V	-	1.2	0.8	-	0.8	-	0.8	V
V _{OH}	HIGH-level	$V_{I} = V_{IH}$ or V_{IL} ; $V_{CC} = 4.5 V$								
	output voltage	I _O = -20 μA	4.4	4.5	-	4.4	-	4.4	-	V
		$I_{O} = -4.0 \text{ mA}$	3.98	4.32	-	3.84	-	3.7	-	V
V _{OL}	LOW-level	$V_{I} = V_{IH}$ or V_{IL} ; $V_{CC} = 4.5 V$								
	output voltage	I_{O} = 20 μ A; V_{CC} = 4.5 V	-	0	0.1	-	0.1	-	0.1	V
		$I_0 = 5.2 \text{ mA}; V_{CC} = 6.0 \text{ V}$	-	0.15	0.26	-	0.33	-	0.4	V
lı	input leakage current	$V_1 = V_{CC}$ or GND; $V_{CC} = 6.0 V$	-	-	±0.1	-	±1	-	±1	μA
I _{CC}	supply current	$\label{eq:VI} \begin{array}{l} V_{I} = V_{CC} \text{ or } GND; \ I_{O} = 0 \ A; \\ V_{CC} = 6.0 \ V \end{array}$	-	-	8	-	80	-	160	μΑ
ΔI _{CC}	additional supply current	per input pin; $V_I = V_{CC} - 2.1 \text{ V}; I_O = 0 \text{ A};$ other inputs at V_{CC} or GND; $V_{CC} = 4.5 \text{ V}$ to 5.5 V	-	100	360	-	450	-	490	μA
CI	input capacitance		-	3.5	-	-	-	-	-	pF

Table 6. Static characteristics ... continued

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10. Dynamic characteristics

Table 7. Dynamic characteristics

GND = 0 V; $t_r = t_f = 6$ ns; $C_L = 50$ pF; test circuit see Figure 10; unless otherwise specified

Symbol	Parameter	Conditions		1	25 °C		-40 °C t	o +85 °C	-40 °C to	o +125 °C	Unit
			N	lin	Тур	Max	Min	Max	Min	Мах	
74HC164	4										
t _{pd}	propagation	CP to Qn; see Figure 7	<u>[1]</u>								
	delay	$V_{CC} = 2.0 V$		-	41	170	-	215	-	255	ns
		$V_{CC} = 4.5 V$		-	15	34	-	43	-	51	ns
		$V_{CC} = 5.0 \text{ V}; \text{ C}_{L} = 15 \text{ pF}$		-	12	-	-	-	-	-	ns
		$V_{CC} = 6.0 V$		-	12	29	-	37	-	43	ns
t _{PHL}	HIGH to LOW	MR to Qn; see Figure 8									
	propagation delay	$V_{CC} = 2.0 V$		-	39	140	-	175	-	210	ns
	uelay	$V_{CC} = 4.5 V$		-	14	28	-	35	-	42	ns
		$V_{CC} = 5.0 \text{ V}; \text{ C}_{L} = 15 \text{ pF}$		-	11	-	-	-	-	-	ns
	$V_{CC} = 6.0 V$		-	11	24	-	30	-	36	ns	
t _t	transition time	see Figure 7	[2]								
		$V_{CC} = 2.0 V$		-	19	75	-	95	-	110	ns
		$V_{CC} = 4.5 V$		-	7	15	-	19	-	22	ns
		$V_{CC} = 6.0 V$		-	6	13	-	16	-	19	ns
t _W	pulse width	CP HIGH or LOW; see <u>Figure 7</u>									
		$V_{CC} = 2.0 V$	ε	30	14	-	100	-	120	-	ns
		$V_{CC} = 4.5 V$	1	16	5	-	20	-	24	-	ns
		$V_{CC} = 6.0 V$	1	14	4	-	17	-	20	-	ns
		MR LOW; see Figure 8									
		$V_{CC} = 2.0 V$	6	50	17	-	75	-	90	-	ns
		$V_{CC} = 4.5 V$	1	12	6	-	15	-	18	-	ns
		$V_{CC} = 6.0 V$	1	10	5	-	13	-	15	-	ns
t _{rec}	recovery time	MR to CP; see Figure 8									
		$V_{CC} = 2.0 V$	6	60	17	-	75	-	90	-	ns
		$V_{CC} = 4.5 V$	1	12	6	-	15	-	18	-	ns
		$V_{CC} = 6.0 V$	1	10	5	-	13	-	15	-	ns
t _{su}	set-up time	DSA, and DSB to CP; see <u>Figure 9</u>									
		$V_{CC} = 2.0 V$	6	50	8	-	75	-	90	-	ns
		$V_{CC} = 4.5 V$	1	12	3	-	15	-	18	-	ns
		$V_{CC} = 6.0 V$	1	10	2	-	13	-	15	-	ns
ĥ	hold time	DSA, and DSB to CP; see <u>Figure 9</u>									
		V _{CC} = 2.0 V	4	+4	-6	-	4	-	4	-	ns
		V _{CC} = 4.5 V	4	+4	-2	-	4	-	4	-	ns
		$V_{CC} = 6.0 V$	4	+4	-2	-	4	-	4	-	ns
4HC_HCT164		All information provide								(P B.V. 2010. All ri	

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Symbol	Parameter	Conditions			25 °C		−40 °C t	o +85 °C	–40 °C to	o +125 °C	Unit
				Min	Тур	Max	Min	Max	Min	Max	-
f _{max}	maximum	for Cp, see <u>Figure 7</u>		I					I		
	frequency	$V_{CC} = 2.0 V$		6	23	-	5	-	4	-	MHz
		$V_{CC} = 4.5 V$		30	71	-	24	-	20	-	MHz
		$V_{CC} = 5.0 \text{ V}; \text{ C}_{L} = 15 \text{ pF}$		-	78	-	-	-	-	-	MHz
		$V_{CC} = 6.0 V$		35	85	-	28	-	24	-	MHz
C _{PD}	power dissipation capacitance	per package; $V_I = GND$ to V_{CC}	<u>[3]</u>	-	40	-	-	-	-	-	pF
74HCT16	64										
t _{pd}	propagation	CP to Qn; see Figure 7	[1]								
	delay	$V_{CC} = 4.5 V$		-	17	36	-	45	-	54	ns
		$V_{CC} = 5.0 \text{ V}; \text{ C}_{L} = 15 \text{ pF}$		-	14	-	-	-	-	-	ns
t _{PHL}		MR to Qn; see Figure 8									
propagation delay	propagation	$V_{CC} = 4.5 V$		-	19	38	-	48	-	57	ns
	uelay	$V_{CC} = 5.0 \text{ V}; \text{ C}_{L} = 15 \text{ pF}$		-	16	-	-	-	-	-	ns
t _t trans	transition time	see Figure 7	[2]								
		$V_{CC} = 4.5 V$		-	7	15	-	19	-	22	ns
t _W	pulse width	CP HIGH or LOW; see <u>Figure 7</u>									
		$V_{CC} = 4.5 V$		18	7	-	23	-	27	-	ns
		MR LOW; see Figure 8									
		$V_{CC} = 4.5 V$		18	10	-	23	-	27	-	ns
t _{rec}	recovery time	MR to CP; see Figure 8									
		$V_{CC} = 4.5 V$		16	7	-	20	-	24	-	ns
t _{su}	set-up time	DSA, and DSB to CP; see <u>Figure 9</u>									
		$V_{CC} = 4.5 V$		12	6	-	15	-	18	-	ns
t _h	hold time	DSA, and DSB to CP; see <u>Figure 9</u>									
		$V_{CC} = 4.5 V$		+4	-2	-	4	-	4	-	ns
f _{max}	maximum	for Cp, see Figure 7									
	frequency	$V_{CC} = 4.5 V$		27	55	-	22	-	18	-	MHz
		$V_{CC} = 5.0 \text{ V}; \text{ C}_{L} = 15 \text{ pF}$		-	61	-	-	-	-	-	MF

Table 7. Dynamic characteristics ... continued

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Symbol	Parameter	Conditions		25 °C		°C –40 °C to +85 °C		–40 °C to +125 °C		Unit
			Min	Тур	Max	Min	Max	Min	Max	
C _{PD}	power dissipation capacitance	per package; V_{I} = GND to V_{CC} – 1.5 V	3] _	40	-	-	-	-	-	pF

Table 7. **Dynamic characteristics** ... continued

[1] t_{pd} is the same as t_{PHL} and t_{PLH} .

[2] t_t is the same as t_{THL} and t_{TLH} .

[3] C_{PD} is used to determine the dynamic power dissipation (P_D in μW):

 $P_D = C_{PD} \times V_{CC}^2 \times f_i \times N + \sum (C_L \times V_{CC}^2 \times f_o)$ where: f_i = input frequency in MHz;

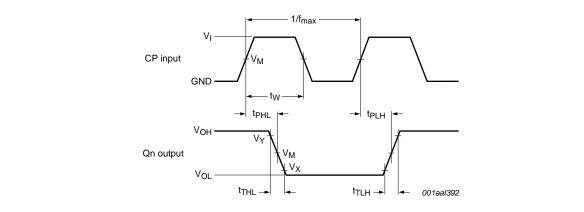
 $f_o = output frequency in MHz;$

C_L = output load capacitance in pF;

 V_{CC} = supply voltage in V;

N = number of inputs switching;

 $\Sigma (C_L \times V_{CC}^2 \times f_o)$ = sum of outputs.



(1) Measurement points are given in Table 8.

 V_{OL} and V_{OH} are typical voltage output levels that occur with the output load.

Waveforms showing the clock (CP) to output (Qn) propagation delays, the clock pulse width, the output Fig 7. transition times and the maximum clock frequency

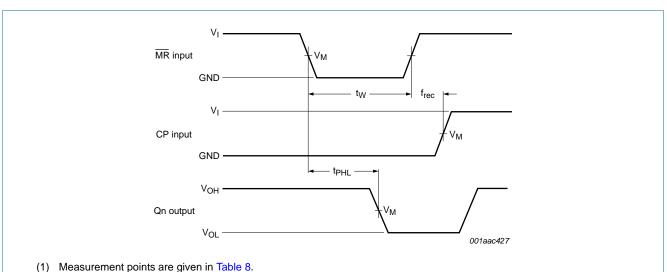
Table 8. Measurem	ient points			
Туре	Input	Output		
	V _M	V _M	V _X	V _Y
74HC164	0.5V _{CC}	0.5V _{CC}	0.1V _{CC}	0.9V _{CC}
74HCT164	1.3 V	1.3 V	0.1V _{CC}	0.9V _{CC}

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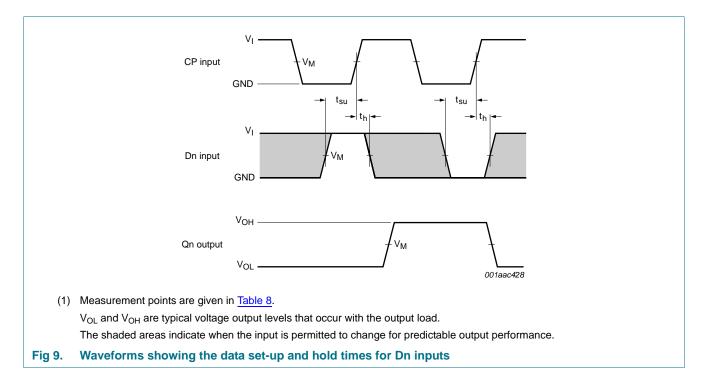
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 V_{OL} and V_{OH} are typical voltage output levels that occur with the output load.





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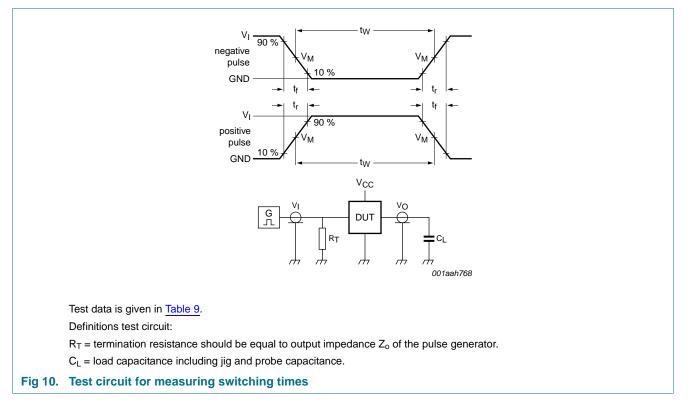


Table 9. Test data

Туре	Input		Load	Test
	VI	t _r , t _f	CL	
74HC164	V _{CC}	6.0 ns	15 pF, 50 pF	t _{PLH} , t _{PHL}
74HCT164	3.0 V	6.0 ns	15 pF, 50 pF	t _{PLH} , t _{PHL}

8-bit serial-in, parallel-out shift register

11. Package outline

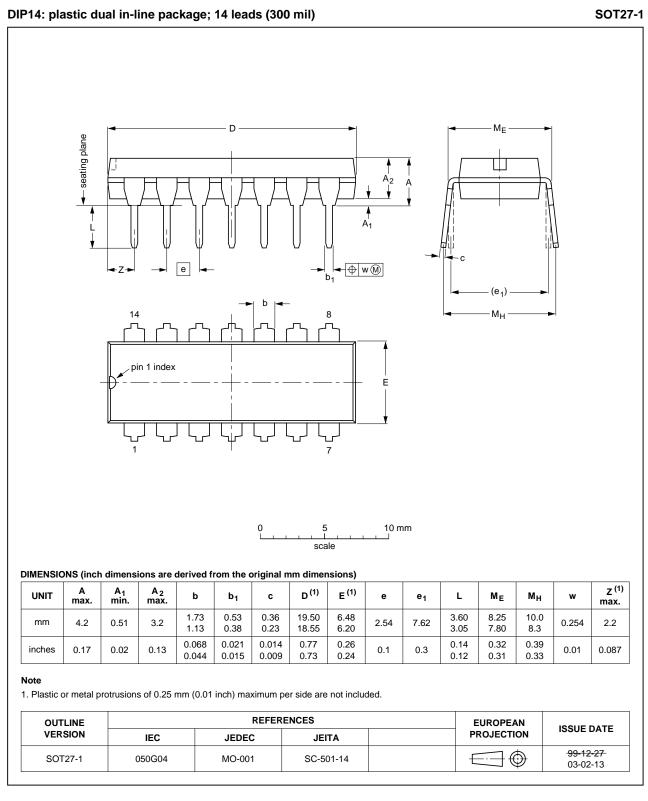


Fig 11. Package outline SOT27-1 (DIP14)

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8-bit serial-in, parallel-out shift register

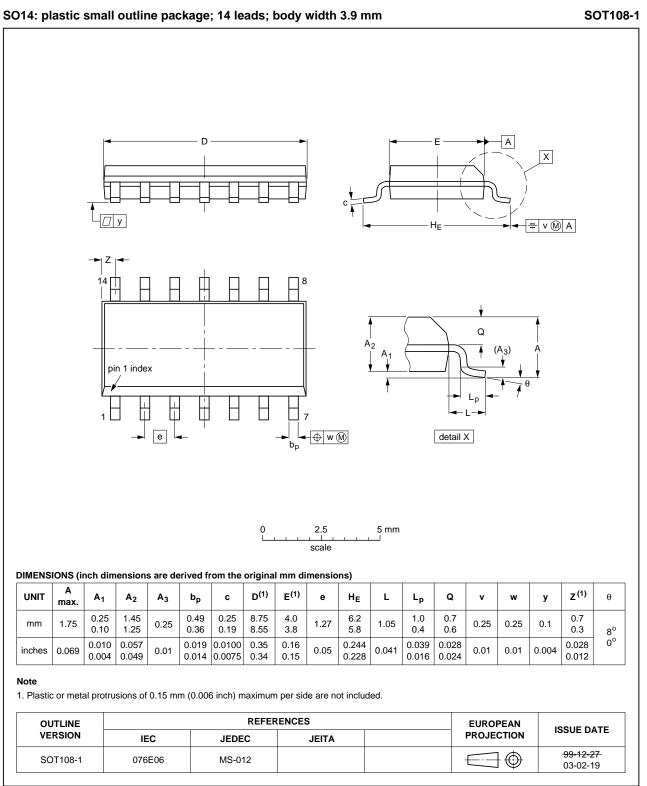


Fig 12. Package outline SOT108-1 (SO14)

8-bit serial-in, parallel-out shift register

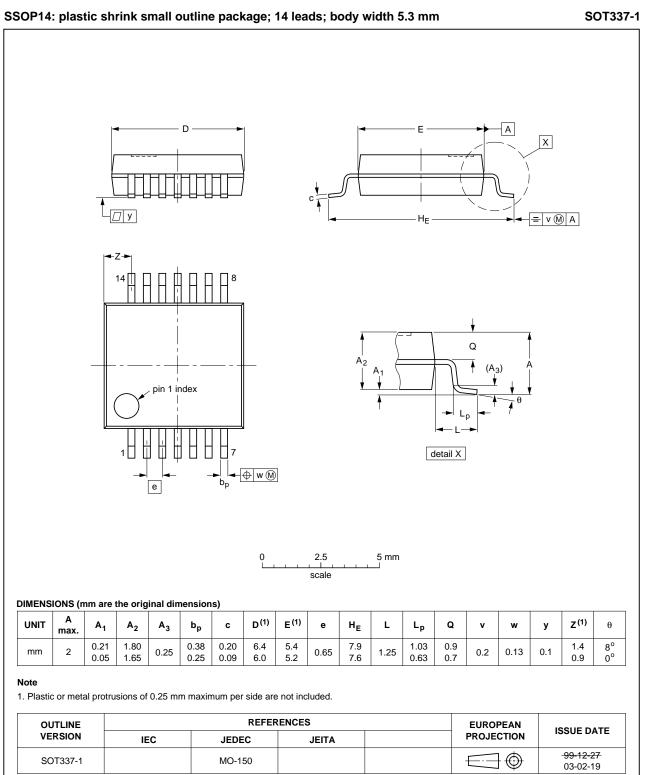


Fig 13. Package outline SOT337-1 (SSOP14)

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8-bit serial-in, parallel-out shift register

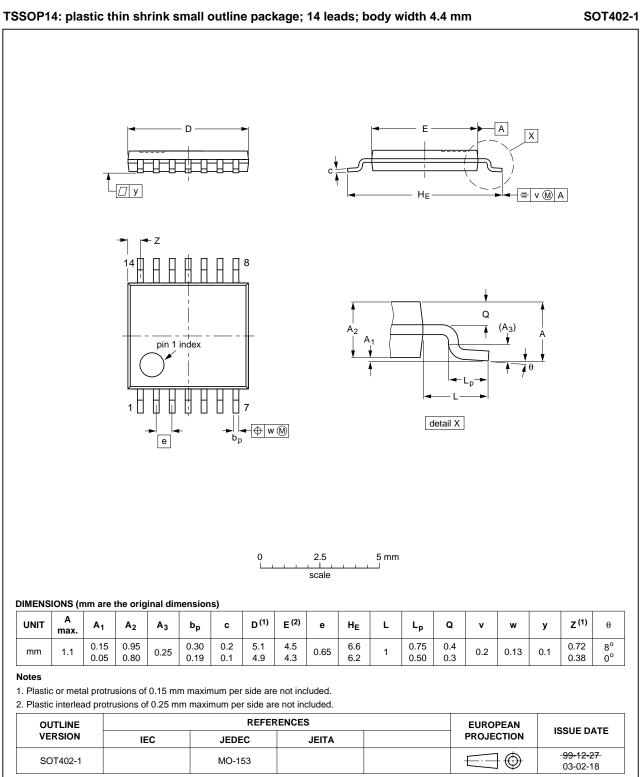
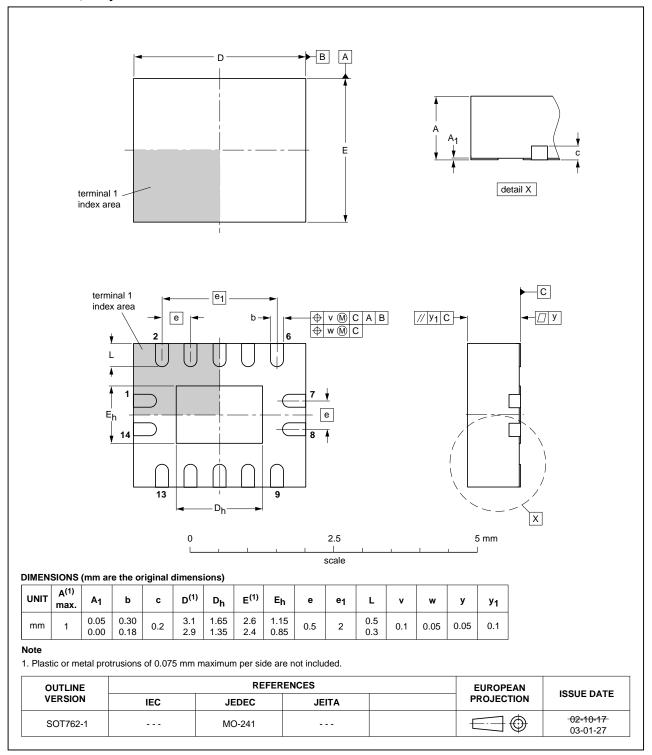


Fig 14. Package outline SOT402-1 (TSSOP14)

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8-bit serial-in, parallel-out shift register



DHVQFN14: plastic dual in-line compatible thermal enhanced very thin quad flat package; no leads; 14 terminals; body 2.5 x 3 x 0.85 mm SOT762-1

Fig 15. Package outline SOT762-1 (DHVQFN14)

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8-bit serial-in, parallel-out shift register

12. Abbreviations

Acronym CMOS	Description Complementary Metal-Oxide Semiconductor Device Under Test
CMOS	
	Davias Under Toot
DUT	Device Order Test
ESD	ElectroStatic Discharge
HBM	Human Body Model
LSTTL	Low-power Schottky Transistor-Transistor Logic
MM	Machine Model
TTL	Transistor-Transistor Logic

13. Revision history

Table 11. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
74HC_HCT164 v.5	20101125	Product data sheet	-	74HC_HCT164 v.4
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74HC_HCT164 v.3	20050404	Product data sheet	-	74HC_HCT164_ CNV v.2
74HC_HCT164_CNV v.2	19901201	Product specification	-	-

8-bit serial-in, parallel-out shift register

14. Legal information

14.1 Data sheet status

Document status[1][2]	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

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